

<b>Notice of References Cited</b>	Application/Control No. 10/577,788		Applicant(s)/Patent Under Reexamination NICHOLL ET AL.	
	Examiner JOSEPH M. PELHAM		Art Unit 3742	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,406,944 A	09-1983	Crain et al.	219/388
*	B	US-5,770,835 A	06-1998	Sakuyama et al.	219/388
*	C	US-6,026,748 A	02-2000	Reed et al.	101/424.1
*	D	US-6,204,483 B1	03-2001	Fair et al.	219/388
*	E	US-6,455,222 B1	09-2002	Fukino et al.	430/270.1
*	F	US-6,807,906 B1	10-2004	DeMoore et al.	101/424.1
*	G	US-2004/0226462 A1	11-2004	DeMoore et al.	101/424.1
*	H	US-2005/0181293 A1	08-2005	Lee, Heon	430/098
*	I	US-6,973,874 B2	12-2005	DeMoore et al.	101/424.1
*	J	US-2007/0039501 A1	02-2007	Ohishi, Chikashi	101/463.1
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 03254946 A	11-1991	Japan	SATO et al.	
	O	DE 19614372 A1	10-1996	Germany	NANIWA, MUTSUMI	
	P	WO 2005015318 A1	02-2005	World Intellect	MACHUEL et al.	
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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